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27th IEEE VLSI TEST SYMPOSIUM
Santa Cruz, California, USA
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All submissions are to be made electronically through the VTS website. **The EXTENDED DEADLINE for ALL submissions is November 9th 2008, 10PM GMT+1**. Detailed instructions for submissions are to be found at the conference website **http://www.tttc-vts.org.** Authors will be notified of the disposition of their papers by 9th January 2009. A submission will be considered as evidence that, upon acceptance, the author(s) will present the paper at the symposium, and will submit a final camera-ready version of the paper for inclusion in the proceedings. In the case of innovative practice and special sessions, the organizers commit to submit a session title, abstract, and list of participants for inclusion in the symposium proceedings and program.

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IEEE VLSI Test Symposium
1474 Freeman Drive
Amissville, VA 20106, USA
Tel: +1-540-937-8280 Fax: +1-540-937-7848
Email: tttc@computer.org